OTP E Cocket No.: 50090-265

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

PATENT

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ECHNOLOGY CENTER 302

re Application of

Kiyotoshi UEDA, et al.

Serial No.: 09/766,845

Group Art Unit: 2829

Filed: January 23, 2001

Examiner: P. Patel

For:

METHOD AND APPARATUS FOR TESTING SEMICONDUCTOR INTEGRATED CIRCUIT, AND

SEMICONDUCTOR INTEGRATED CIRCUIT MANUFACTURED THEREBY

THE COMMISSIONER FOR PATENTS AND TRADEMARKS

Washington, DC 20231

Dear Sir:

Transmitted herewith is an Amendment in the above identified application.

No additional fee is required.

Applicant is entitled to small entity status under 37 CFR 1.27

Also attached:

The fee has been calculated as shown below:

	NO. OF CLAIMS	HIGHEST PREVIOUSLY PAID FOR	EXTRA CLAIMS	RATE	FEE
Total Claims	14	20	0	\$18.00 =	\$0.00
Independent Claims	2	3	0	\$84.00 =	\$0.00
		Multiple claims newly presented			\$0.00
		Fee for extension of time			\$0.00
					\$0.00
		Total of Above Calculations			\$0.00

Please charge my Deposit Account No. <u>500417</u> in the amount of \$0.00. An additional copy of this transmittal sheet is submitted herewith.

The Commissioner is hereby authorized to charge payment of any fees associated with this communication or credit any overpayment, to Deposit Account No. 500417, including any filing fees under 37 CFR 1.16 for presentation of extra claims and any patent application processing fees under 37 CFR 1.17.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Date: October 8, 2002